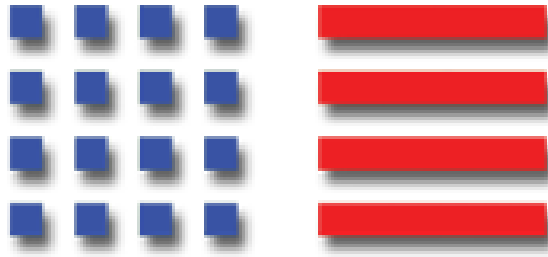


4th Belle II PXD/SVD Workshop and 14th International Workshop on
DEPFET Detectors and Applications



Contribution ID: 86

Type: **not specified**

Wafer-Level Testing of long PXD6 Matricies

Tuesday 22 October 2013 13:30 (15 minutes)

Presenter: AVELLA, Paola

Session Classification: PXD Testsystems